Designer's™ Data Sheet

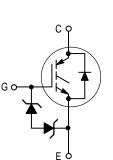
Insulated Gate Bipolar Transistor with Anti-Parallel Diode N-Channel Enhancement-Mode Silicon Gate

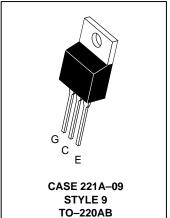
This Insulated Gate Bipolar Transistor (IGBT) is co-packaged with a soft recovery ultra-fast rectifier and uses an advanced termination scheme to provide an enhanced and reliable high voltage-blocking capability. Its new 600 V IGBT technology is specifically suited for applications requiring both a high temperature short circuit capability and a low $V_{CE(on)}$. It also provides fast switching characteristics and results in efficient operation at high frequencies. Co-packaged IGBTs save space, reduce assembly time and cost. This new E-series introduces an energy efficient, ESD protected, and rugged short circuit device.

- Industry Standard TO-220 Package
- High Speed: Eoff = 60 μJ per Amp typical at 125°C
- High Voltage Short Circuit Capability 10 μs minimum at 125°C, 400 V
- Low On–Voltage 2.0 V typical at 8.0 A
- Soft Recovery Free Wheeling Diode is included in the Package
- Robust High Voltage Termination
- ESD Protection Gate-Emitter Zener Diodes



IGBT & DIODE IN TO-220 11 A @ 90°C 15 A @ 25°C 600 VOLTS SHORT CIRCUIT RATED LOW ON-VOLTAGE





MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Rating	Symbol	Value	Unit	
Collector–Emitter Voltage	VCES	600	Vdc	
Collector–Gate Voltage ($R_{GE} = 1.0 M\Omega$)	VCGR	600	Vdc	
Gate-Emitter Voltage — Continuous	VGE	±20	Vdc	
Collector Current — Continuous @ $T_C = 25^{\circ}C$ — Continuous @ $T_C = 90^{\circ}C$ — Repetitive Pulsed Current (1)	IC25 IC90 ICM	15 11 22	Adc Apk	
Total Power Dissipation @ T _C = 25°C Derate above 25°C	PD	96 0.77	Watts W/°C	
Operating and Storage Junction Temperature Range	тј, Т _{stg}	-55 to 150	°C	
Short Circuit Withstand Time (V_{CC} = 400 Vdc, V_{GE} = 15 Vdc, T_J = 125°C, R_G = 20 Ω)	t _{sc}	10	μs	
Thermal Resistance — Junction to Case – IGBT — Junction to Case – Diode — Junction to Ambient	R _θ JC R _θ JC R _θ JA	1.3 2.3 65	°C/W	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	ΤL	260	°C	
Mounting Torque, 6–32 or M3 screw	10	10 lbf∙in (1.13 N∙m)		

(1) Pulse width is limited by maximum junction temperature. Repetitive rating.

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

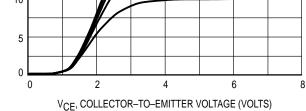
C	characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector-to-Emitter Breakdown (V _{GE} = 0 Vdc, I _C = 250 μ Adc)	V(BR)CES	600	_	_	Vdc
Temperature Coefficient (Posi	ve)			870		mV/°C
Zero Gate Voltage Collector Cur ($V_{CE} = 600 \text{ Vdc}, V_{GE} = 0 \text{ Vdc}$ ($V_{CE} = 600 \text{ Vdc}, V_{GE} = 0 \text{ Vdc}$	c)	ICES			10 200	μAdc
Gate-Body Leakage Current (V	$GE = \pm 20 \text{ Vdc}, \text{ V}_{CE} = 0 \text{ Vdc})$	IGES	—	—	50	μAdc
ON CHARACTERISTICS (1)				-		
Collector-to-Emitter On-State V (V _{GE} = 15 Vdc, I _C = 4.0 Adc) (V _{GE} = 15 Vdc, I _C = 4.0 Adc, (V _{GE} = 15 Vdc, I _C = 8.0 Adc)	0	VCE(on)		1.6 1.5 2.0	1.9 — 2.4	Vdc
		Verus		2.0	2.7	Vdc
Gate Threshold Voltage ($V_{CE} = V_{GE}$, $I_C = 1.0$ mAdc) Threshold Temperature Coeffi	cient (Negative)	VGE(th)	4.0	6.0 10	8.0 —	mV/°C
Forward Transconductance (VC	E = 10 Vdc, I _C = 8.0 Adc)	9fe	_	3.5	_	Mhos
DYNAMIC CHARACTERISTICS	-				1	
Input Capacitance		C _{ies}	—	779	_	pF
Output Capacitance	(V _{CE} = 25 Vdc, V _{GE} = 0 Vdc, f = 1.0 MHz)	C _{oes}	—	81	_	
Transfer Capacitance		C _{res}	—	13	_	1
SWITCHING CHARACTERISTIC	S (1)	•			•	
Turn–On Delay Time		^t d(on)	—	46	—	ns
Rise Time	7	tr	—	34	—	
Turn–Off Delay Time	$(V_{CC} = 360 \text{ Vdc}, I_{C} = 8.0 \text{ Adc},$	^t d(off)	—	102	—	
Fall Time	V _{GE} = 15 Vdc, L = 300 μH, R _G = 20 Ω)	t _f	—	226	—	
Turn–Off Switching Loss	Energy losses include "tail"	E _{off}	—	0.32	0.40	mJ
Turn–On Switching Loss		E _{on}	—	0.11	—	
Total Switching Loss		E _{ts}	—	0.43	—	
Turn–On Delay Time		^t d(on)	—	42	—	ns
Rise Time		tr	—	26	—	
Turn–Off Delay Time	$(V_{CC} = 360 \text{ Vdc}, I_{C} = 8.0 \text{ Adc},$	^t d(off)	—	214	—	
Fall Time	V _{GE} = 15 Vdc, L = 300 μH R _G = 20 Ω, T _J = 125°C)	t _f	—	228	—	
Turn–Off Switching Loss	Energy losses include "tail"	E _{off}	—	0.48	—	mJ
Turn–On Switching Loss		E _{on}	—	0.16	—	1
Total Switching Loss	7	E _{ts}	—	0.64	—	
Gate Charge		QT	—	39.2	—	nC
	(V _{CC} = 360 Vdc, I _C = 8.0 Adc, V _{GE} = 15 Vdc)	Q ₁	—	8.7	—	
		Q2	—	17.4	—	
DIODE CHARACTERISTICS	·	· · · · · · · · · · · · · · · · · · ·		-		
Diode Forward Voltage Drop (I _{EC} = 3.25 Adc) (I _{EC} = 3.25 Adc, T _J = 125°C)		VFEC	_	1.63 1.24		Vdc
$(I_{EC} = 6.5 \text{ Adc})$			1.7	2.0	2.3	

(1) Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

(continued)

ELECTRICAL CHARACTERISTICS - continued (T₁ = 25°C unless otherwise noted)

PIODE CHARACTERISTICS — continued Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s})$ Reverse Recovery Stored Charge Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s})$ Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_J = 125^{\circ}\text{C})$ Reverse Recovery Stored Charge NTERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25 17.5 V 25 12.5 V	trr ta tb QRR trr ta tb QRR		57 18 39 107 91 28 63	 	ns μC ns
Reverse Recovery Stored Charge $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s})$ Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_J = 125^{\circ}\text{C})$ Reverse Recovery Stored Charge $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_J = 125^{\circ}\text{C})$ NTERNAL PACKAGE INDUCTANCE Internal Emitter Inductance Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25 25	^t a ^t b Q _{RR} ^t rr ^t a ^t b	 	18 39 107 91 28 63		μC
Reverse Recovery Stored Charge Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/µs}, T_J = 125°C)$ Reverse Recovery Stored Charge NTERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25	^t b Q _{RR} ^t rr ^t a ^t b		39 107 91 28 63		
Reverse Recovery Stored Charge Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_J = 125^{\circ}\text{C})$ Reverse Recovery Stored Charge NTERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25	Q _{RR} t _{rr} t _a t _b		107 91 28 63		
Reverse Recovery Time $(I_F = 8.0 \text{ Adc}, V_R = 360 \text{ Vdc}, $	t _{rr} t _a t _b		91 28 63		
$(I_{F} = 8.0 \text{ Adc}, V_{R} = 360 \text{ Vdc}, \\ dI_{F}/dt = 200 \text{ A}/\mu\text{s}, T_{J} = 125^{\circ}\text{C})$ Reverse Recovery Stored Charge ITERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25	t _a t _b		28 63		ns
Reverse Recovery Stored Charge ITERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25 25	tb		63		
Reverse Recovery Stored Charge ITERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25 25	-	_		_	
ITERNAL PACKAGE INDUCTANCE Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad) 25	Q _{RR}	l _	075		
Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad)			275	—	μC
(Measured from the emitter lead 0.25" from package to emitter bond pad) 25 25 25 25 25 25 25 2		-	-	-	_
	LE	_	7.5	_	nH
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	1	20 V 7.5 V	/ 15 V		2.5 V



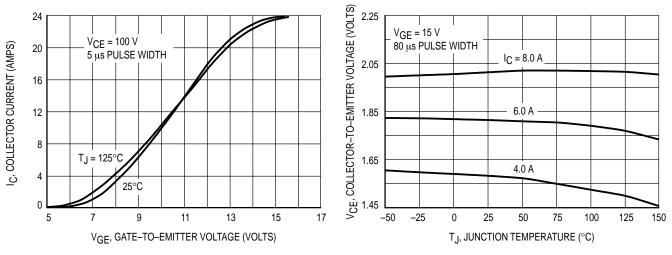


4 V_{CE}, COLLECTOR–TO–EMITTER VOLTAGE (VOLTS)

8

6





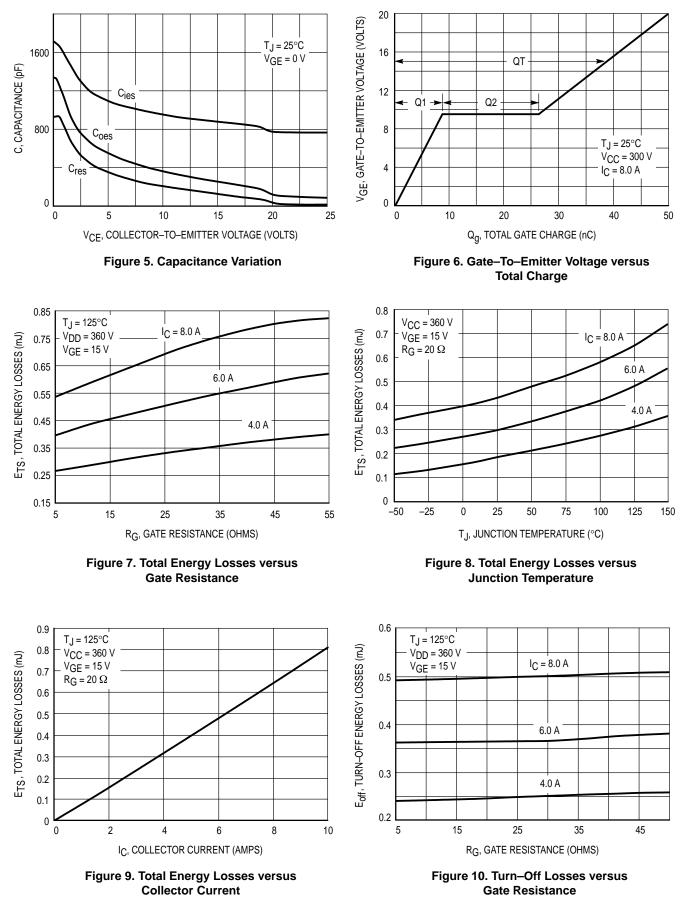
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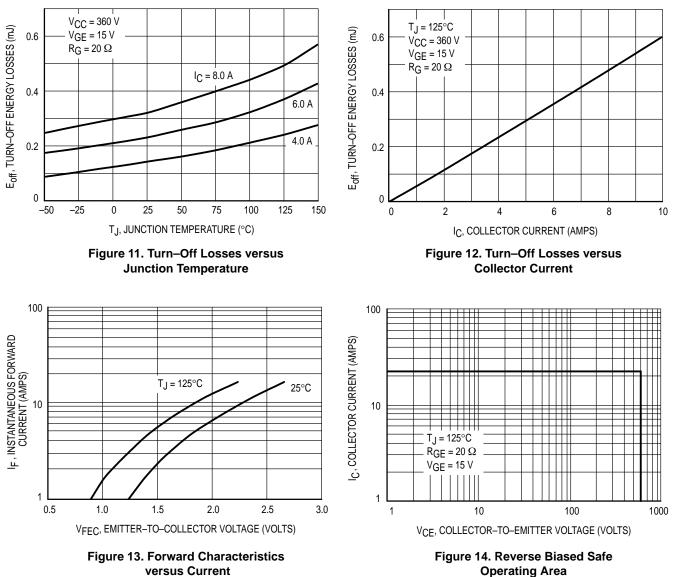
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Figure 3. Transfer Characteristics

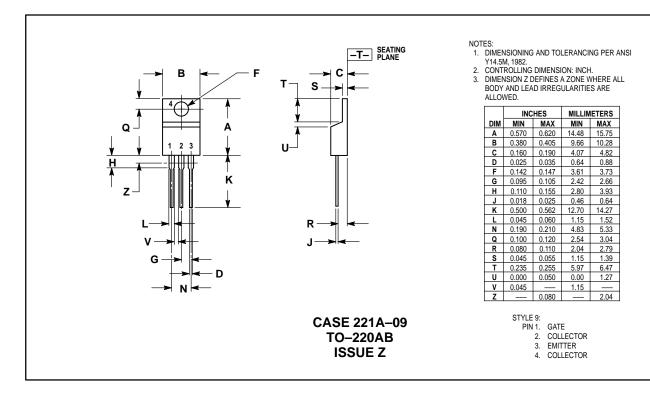
Figure 4. Collector–To–Emitter Saturation **Voltage versus Junction Temperature**



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PACKAGE DIMENSIONS



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